

Notice of References Cited	Application/Control No. 10/577,453	Applicant(s)/Patent Under Reexamination VAINIO ET AL.	
	Examiner MARCOS BATISTA	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0186845 A1	12-2002	Dutta et al.	380/247
*	B	US-2003/0195010 A1	10-2003	Pattabiraman et al.	455/517
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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